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Application Notes

- AN 39 IEEE 1149.1 (JTAG) Boundary-Scan Testing in Altera Devices
- AN 77 Understanding MAX 9000 Timing
- AN 85 In-System Programming Times for MAX Devices
- AN 88 Using the Jam Language for ISP & ICR via an Embedded Processor
- AN 94 Understanding MAX 7000 Timing
- AN 95 In-System Programmability in MAX Devices
- AN 100 In-System Programmability Guidelines
- AN 122 Using Jam STAPL for ISP & ICR via an Embedded Processor

Data Sheets

- BitBlaster Serial Download Cable Data Sheet
- ByteBlaster Parallel Port Download Cable Data Sheet
- ByteBlasterMV Parallel Port Download Cable Data Sheet
- MasterBlaster Serial/USB Communications Data Sheet
- MAX 9000 Programmable Logic Device Family Data Sheet
- MAX 7000 Programmable Logic Device Family Data Sheet
- MAX 7000A Programmable Logic Device Family Data Sheet
- MAX 7000B Programmable Logic Device Family Data Sheet
- MAX 3000A Programmable Logic Device Family Data Sheet

General Information

- In-Circuit Test Vendor Support
- Saving Board Space with MAX 7000S & MAX 7000A TQFP Packages

Jam Programming & Test Language

- Third-Party Programmer Support for the Jam Programming & Test Language
- Jam Programming & Test Language Specification

Product Information Bulletins

- PIB 24 [Advantages of ISP-Based PLDs over Traditional PLDs](#)
- PIB 26 [Concurrent Programming through the JTAG Interface for MAX Devices](#)
- PIB 27 [Jam Programming & Test Language Overview](#)

Technical Briefs

- TB 28 [Advantages of ISP-Based CPLDs](#)
- TB 32 [ISP Programming Methods & Ordering Codes](#)